

<b>Notice of References Cited</b>	Application/Control No. 10/667,730	Applicant(s)/Patent Under Reexamination SCHMIDT ET AL.	
	Examiner Andy Huynh	Art Unit 2818	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,640,343	06-1997	Gallagher et al.	365/171
	B	US-5,962,905	10-1999	Kamiguchi et al.	257/421
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	00/59052	10-2000	WO	Hehn et al.	
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Fiederling, R. et al.: "Injection and Detection of a Spin-Polarized Current in a Light-Emitting Diode", Nature, Vol. 402, December 16, 1999, pp. 787-790
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.